In re Appln. of NISHIGUCHI et al. Application No. Unassigned

ABSTRACT AMENDMENTS

Replace the Abstract with:

A semiconductor laser device has an n-GaAs substrate (1). On the n-GaAs substrate (1), by turns, are an n-AlGaInP elad cladding layer (2), an AlGaInP/GaInP MQW active layer (3), a p-AlGaInP first elad cladding layer (4), a single layer p-Al_xGa_{1-x}As-ESL(5) of a single layer etching stopping layer, a p-AlGaInP second elad cladding layer (7) with a stripe-form protrusion (6), and a p-GaAs contact layer (8) are provided. The portion, other than the stripe-form protrusion (6), of the p-AlGaInP second elad cladding layer (7) is covered with an insulative insulating film (9). The refractive index of the p-Al_xGa_{1-x}As-ESL (5) is nearly equal to the refractive index of each of the elad lower, first upper, and second upper cladding layers (2), (4) and (7).